

Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/696,175	AYNIE ET AL.
Examiner	Art Unit	
Jason M. Han	2875	

ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
362	511	362	518	522	540	327		
INTERNATIONAL CLASSIFICATION								
F	2	1	V	9/00				
				/				
				/				
				/				
				/				
Jason Han 5/16/2005 (Assistant Examiner) (Date)		Stephen Husar Primary Examiner <i>Stephen Husar 5/20/05</i> (Primary Examiner) (Date)					Total Claims Allowed: 29	
<i>RL</i> 5/20/05 (Legal Instruments Examiner) (Date)		O.G. Print Claim(s)		O.G. Print Fig.				
		1		2				

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	5	35	65	95	125	155	185
6	6	36	66	96	126	156	186
7	7	37	67	97	127	157	187
8	8	38	68	98	128	158	188
9	9	39	69	99	129	159	189
10	10	40	70	100	130	160	190
11	11	41	71	101	131	161	191
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